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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Leonard H. Bieman
Title: SCANNING PHASE MEASURING METHOD AND SYSTEM FOR AN OBJECT AT A VISION STATION
Docket No.: 139.045USR
Filed: July 8, 1998
Examiner: Hoa Q. Pham
Serial No.: 09/111,978
Due Date: November 30, 1999
Group Art Unit: 2877

Assistant Commissioner for Patents
Washington, D.C. 20231

We are transmitting herewith the following attached items (as indicated with an "X"):

- ☒ A return postcard.
- ☒ A Supplemental Information Disclosure Statement (2 pgs.), Form 1449 (1 pg.), and copies of 8 cited references.
- ☒ International Search Reports PCT/US 99/15411 and PCT/US 99/15412 (2 pgs each.).

Please consider this a PETITION FOR EXTENSION OF TIME for sufficient number of months to enter these papers and please charge any additional required fees or credit overpayment to Deposit Account No. 19-0743.

CERTIFICATE UNDER 37 CFR 1.8: The undersigned hereby certifies that this Transmittal Letter and the paper, as described above, are being deposited in the United States Postal Service, as first class mail, in an envelope addressed to: Assistant Commissioner for Patents, Washington, D.C. 20231, on this 19 day of November, 1999.

SCHWEGMAN, LUNDBERG, WOESSNER & KLUTH, P.A.
P.O. Box 2938, Minneapolis, MN 55402 (612-373-6900)

By: Charles A. Lemaire
Atty: Charles A. Lemaire
Reg. No. 36,198

Customer Number **21186**

(GENERAL)

S/N 09/111,978



PATENT

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OBJECT AT A VISION STATION

#17

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT
AND CERTIFICATION UNDER 1.97(e)(1)

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Assistant Commissioner for Patents
Washington, D.C. 20231

TECHNOLOGY CENTER 2800

In compliance with the duty imposed by 37 C.F.R. § 1.56, and in accordance with 37 C.F.R. §§ 1.97 *et. seq.*, the enclosed materials are brought to the attention of the Examiner for review in connection with the above-identified patent application. Pursuant to the provisions of MPEP 609, Applicant requests that a copy of the 1449 form, marked as being considered and initialled by the Examiner, be returned with the next official communication.

The attached references were discovered as a result of Search Reports in related copending foreign patent applications. Enclosed for the Examiner's information are copies of the documents and the International Search Reports.

CERTIFICATION UNDER 37 C.F.R. § 1.97(e)(1)

The undersigned attorney hereby certifies that each item of information contained in this Supplemental Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

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Dkt: 139.045USR

Applicant respectfully request consideration of these references during prosecution of the above-identified matter. The Examiner is invited to contact the Applicant's Representatives at the below-listed telephone number if there are any questions regarding this communication.

Respectfully submitted,

LEONARD H. BIEMAN

By his Representatives,

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Date

19 November 1999

CAL/maf

By



Charles A. Lemaire

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I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to Assistant Commissioner of Patents, Washington, D.C. 20231 on November 19, 1999.

Name

Charles A. Lemaire

Signature

